

<b>Notice of References Cited</b>	Application/Control No. 10/082,470	Applicant(s)/Patent Under Reexamination CHALKE ET AL.	
	Examiner Hai Tran	Art Unit 3694	Page 1 of 1

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*	B	US-6,338,047	01-2002	Wallman, Steven M. H.	705/36R
*	C	US-6,064,986	05-2000	Edelman, Fredric M.	705/36R
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	M	US-			

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**NON-PATENT DOCUMENTS**

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